

09-966046

SC0194WD

- 17 -

## SEMICONDUCTOR WAFER IDENTIFICATION

Abstract of the Disclosure

5

A semiconductor wafer (10), a method of providing information on a semiconductor wafer (10), a system of semiconductor wafer (10) and reading means, and a method of reading information from a semiconductor wafer (10) are provided. The invention is characterized by magnetic means (14) as information carrier and the respective magnetic sensors (26) to read such information.

(Fig. 5)

中原書局影印